

# MONOLITHIC AC-LGADS:

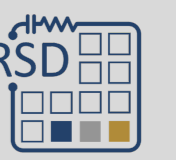
## A New Frontier in High-Performance Particle Tracking in 4 Dimensions

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### MOTIVATIONS

**Technology challenges** foreseen in **near-future** and in **major upgrades of present** high-energy physics experiments are essentially related to **detector requirements** such

- low **power consumption**: few mW/cm<sup>2</sup>
- low **material budget**:  $X/X_0 \lesssim 0.1$
- low **cost** per unit area
- very high **space resolution**: few microns
- high **time resolution**:  $O(30\text{ps})$

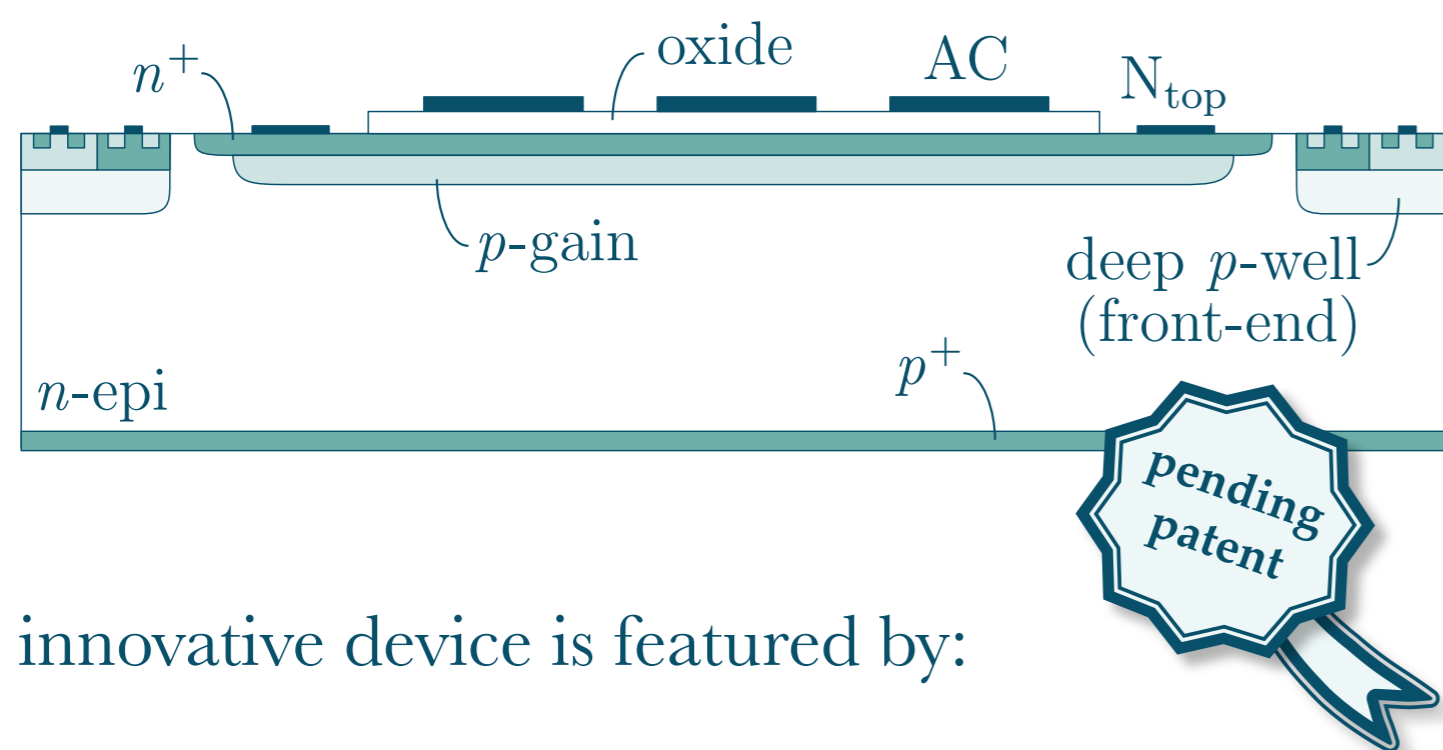
The first three items can be addressed through the use of **monolithic integration**.

**Precise tracking** can be achieved with a combination of **pixel detectors** and **Low-Gain Avalanche Diodes (LGADs)**. However, it is possible to **simultaneously** have good precision in both **space** and **time reconstruction** with the same sensor by exploiting the **Resistive AC-Coupled Silicon Detectors (RSD)** paradigm [1].

we need to **integrate AC-LGADs** in the **CMOS process**

### A NEW SENSOR IDEA

The goal is to design a silicon detector for **4D-tracking** characterized by **high precision** of both **space and time reconstruction**. This is the so-called **monolithic AC-LGAD**

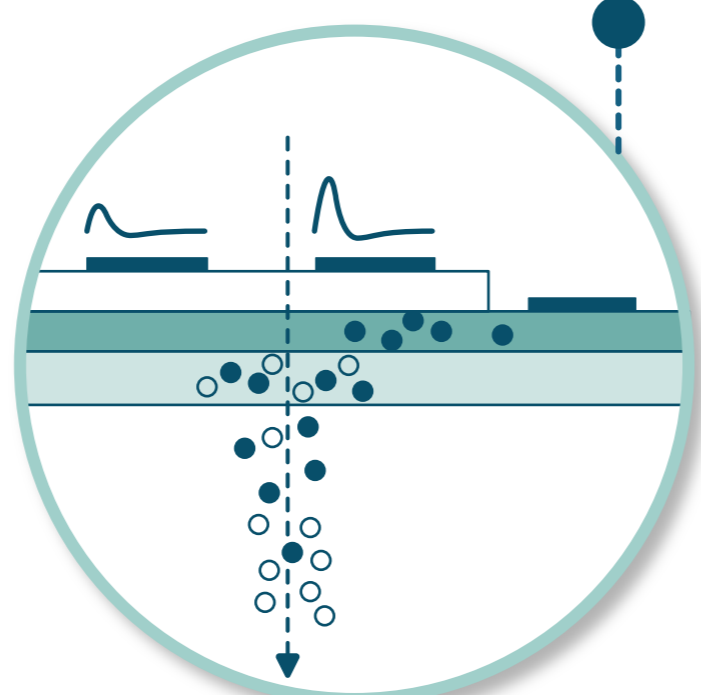


This innovative device is featured by:

- a *p*-type **continuous gain layer**
- a *n*-type **continuous resistive cathode**
- a **dielectric** stack on top of the active area
- peripheral *p*-wells **hosting the FEE**

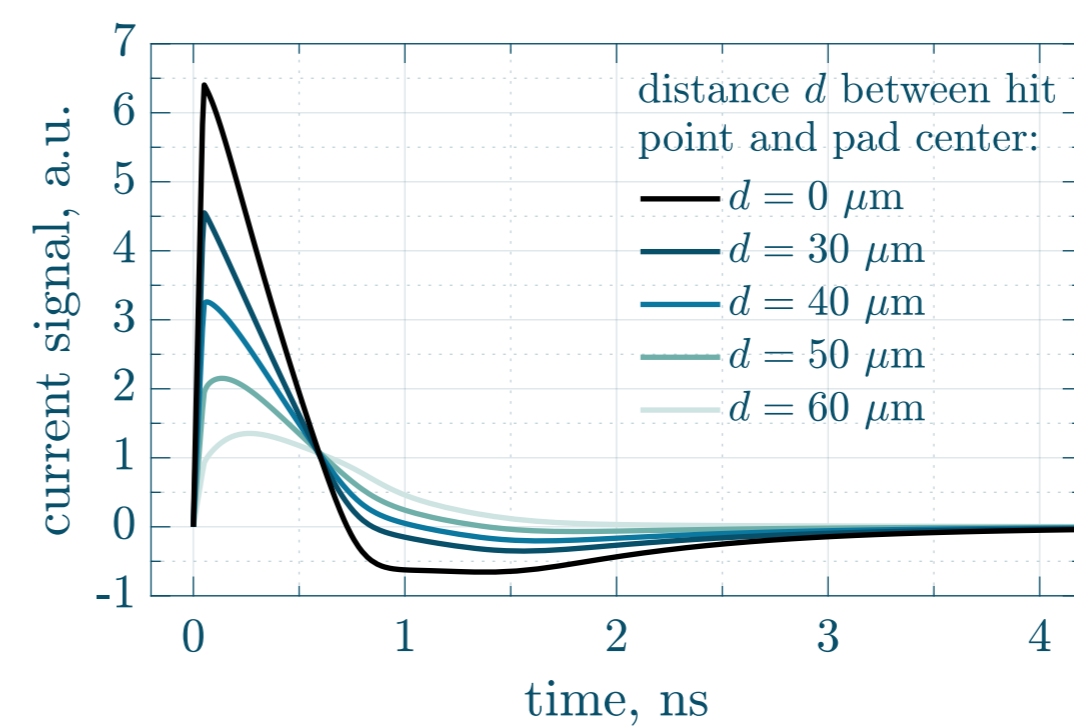
The **multiplied electrons** are **slowed down** in the resistive layer, so that a signal can be induced into AC pads through **capacitive coupling**.

Signal **amplitude** decreases with the **distance** from the **hit point**.

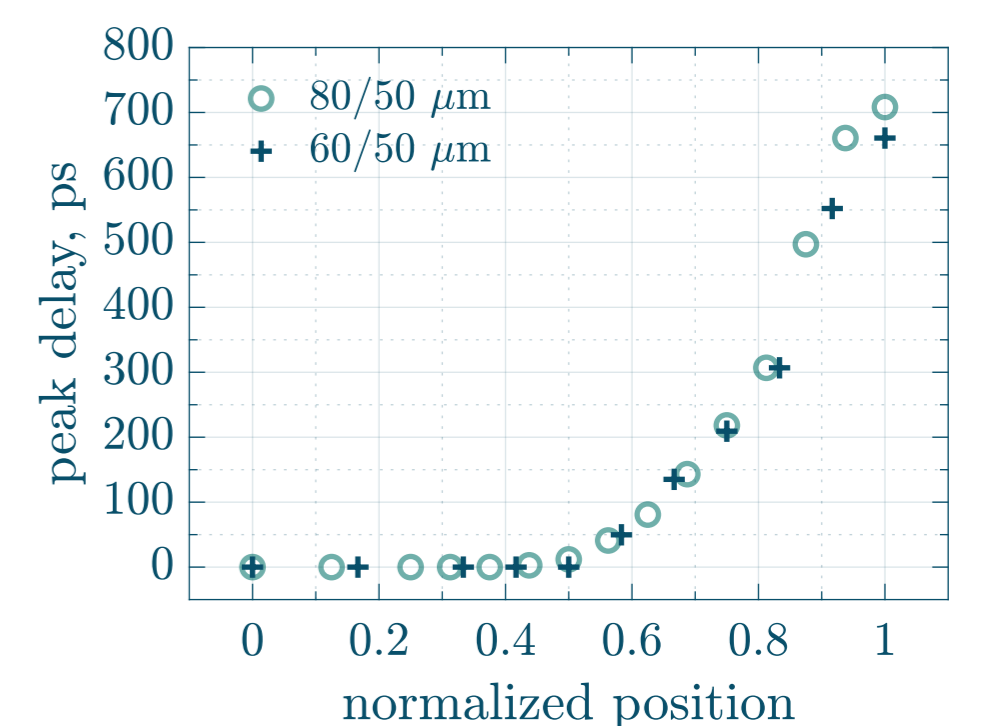
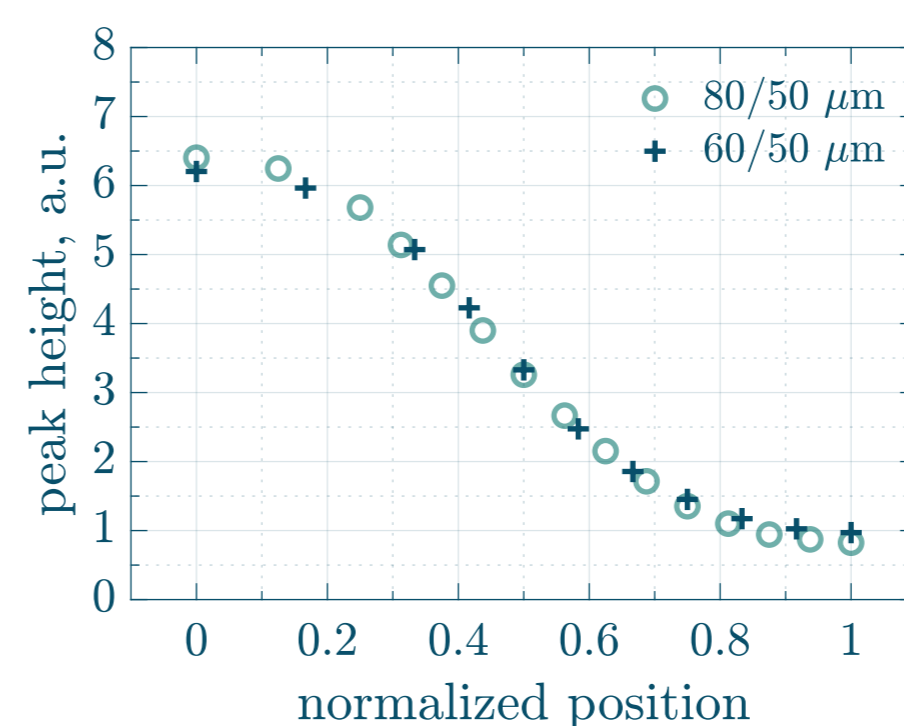


### PROOF-OF-CONCEPT

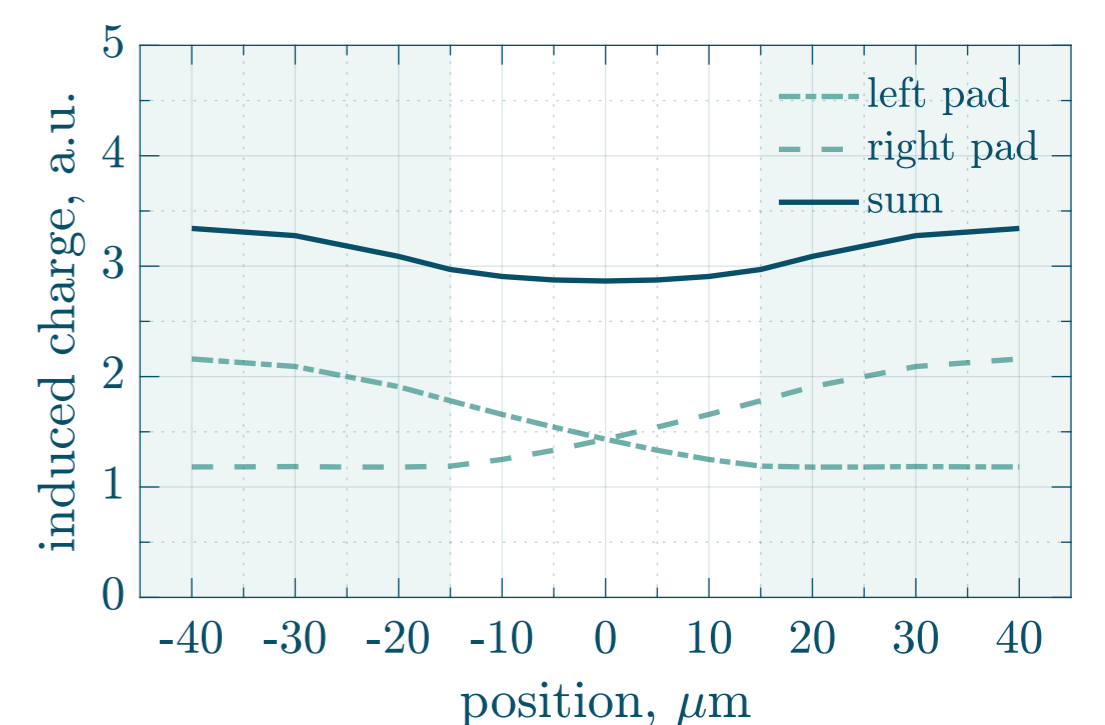
To test the feasibility of **monolithic AC-LGAD** sensors in **110 nm technology**, extensive **numerical simulations** have been conducted (TCAD and Monte Carlo).



A scan with a MIP in a **50-μm-pad** sensor shows the same trend of the **signal height**, as well as the **peak delay, versus hit position** whatever the pitch size

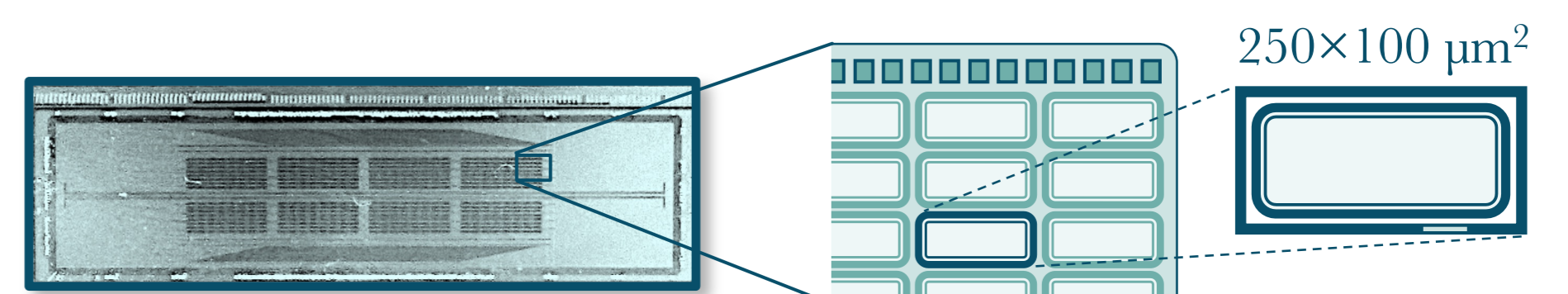


The sum of **induced charges** in two neighboring AC pads is quite **homogeneous** denoting a **100% fill-factor**



### TOWARDS A PROTOTYPE

We successfully produced in 2023 a **first batch** of sensors, embodying either the **gain layer** and the **front-end electronics**, which demonstrated that the **LGAD technology** and the **CMOS process** (110 nm) are compatible [2].



**CMOS-LGAD**

“MadPix” (2023)

off-pixel **buffers**  
+  
in-pixel **pre-amplifier**

### References

- [1] M. Mandurrino *et al.*, IEEE EDL 40(11), 1780-1783, 2019, doi: 10.1109/LED.2019.2943242
- [2] T. Corradino *et al.*, JINST 19, C02036, 2024, doi: 10.1088/1748-0221/19/02/C02036